Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/542,147	YAMADA ET AL.	
Examiner	Art Unit	
Benjamin T. Liu	2826	

SEARCHED			
Class	Subclass	Date	Examiner
430	57	10/17/2006	· BTL
136	258	10/17/2006	BTL
257	458	10/17/2006	BTL
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT	TES STRATEGY)
	DATE	EXMR
EAST search see attached printout	10/17/2006	BTL